

**Jesse Dyer**

Attorney
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Jesse is a seasoned litigator, focusing his intellectual property practice on patent litigation. He has experience in all stages of litigation from pre-suit investigation through appeal and has served as second chair in several trials. Outside of federal court, Jesse has been involved in Patent Trial and Appeal Board proceedings, Section 337 investigations at the U.S. International Trade Commission (ITC), and alternative dispute resolutions. Jesse also leverages his trial experience to assist clients with freedom-to-operate matters, due diligence investigations, patent drafting, invalidity/infringement opinions, and licensing transactions.

Jesse has experience working on a wide range of technologies such as pharmaceuticals (e.g., small molecule, antibodies, and mRNA), medical devices (e.g., drug infusion pumps and inflatable bone tamps), recombinant proteins (e.g., Factor VIII), drug development (e.g., NK cells), power tools, batteries, vacuums, carburetors, wireless network communications, software, vehicle floor mats, and kitty litter.

Jesse has an active pro bono practice. Working with the National Immigrant Justice Center, he has successfully obtained asylum for two different families. He has also represented prisoners in civil rights cases.

Education

Purdue University
2004, B.S., Chemical Engineering

DePaul University College of Law
2012, J.D., *Magna Cum Laude*

Admissions

Bar Admissions
2012, Illinois

Practices

Copyright
Counseling, Opinions + Licensing
Jury Trials
Litigation

PTAB Litigation
Trademarks

Industries

Chemistry + Chemical Engineering
Electrical + Computer Technologies
Life Sciences + Pharmaceuticals
Medical Devices

Recent News + Events + Related Publications

NEWS - 03.04.25

PTAB Highlights | Takeaways from Recent Decisions in Post-Issuance Proceedings

NEWS - 08.07.24

PTAB Highlights | Takeaways from Recent Decisions

NEWS - 06.01.23

PTAB Highlights | Takeaways from Recent Decisions in Post-Issuance Proceedings